

To day

## Options

Day 14

I Feedback Survey

II Last time

III Diffraction by Slits

I See feedback solder

II Found

$$I_r = \frac{1}{2} E_r E_r^* = I_0 \left[ \frac{2r^2(1-\cos S)}{((+r^4) - 2r^2 \cos S)} \right]$$

$$I_t = I_0 \frac{\frac{4}{\pi} \frac{I}{r}}{1 + \left(\frac{2r}{1-r}\right)^2 \sin^2 \frac{S}{2}}$$

- Sharp transmission peaks make this a useful Peaks interferometer.

$S = 2k \text{ and } \cos \theta_t + 2\phi$   
is sensitive to changes in distance  
 $d$ ,  $\lambda_0$ , and the angles  $\theta_i$ ,  $\theta_t$ .

With absorption we let

$$T = t t' , R = r^2 \text{ and have } T + R = 1 - A.$$

Then

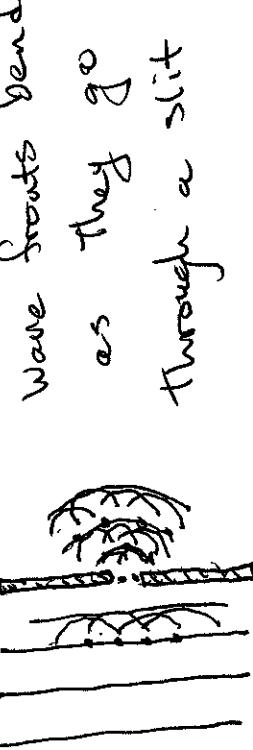
$$I_{max} = I_0 \left( 1 - \frac{A}{1-R} \right)^2$$

• Introduced Finesse  $\frac{\text{dist. b/w maxima}}{\text{width of transition maxima}}$

$$\mathcal{F} = \frac{FSR}{FWHM} = \frac{\text{width of transition maxima}}{\text{width of transition maxima}}$$

March 30th, 2017 PI/3

III On the very first day of class  
we introduced the notion of diffraction  
via Huygen's principle



A better treatment of diffraction results when you include interference effects between the various wavelets. The

Resulting principle is the

Huygen's-Fresnel principle:

- Each pt of a wavefront serves as a source of 2nd-order spherical waves
- The amplitude of the field is the superposition (interference) of all of the secondary waves.

We will be shortly building towards a rigorous justification of this principle

and so,

A simple model of this

$$r_1 \rightarrow (r_2 - r_1) \approx ds \sin\theta$$



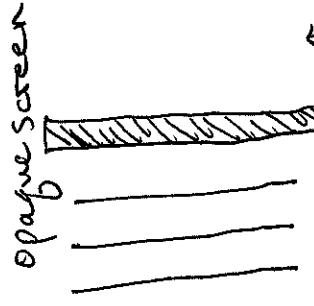
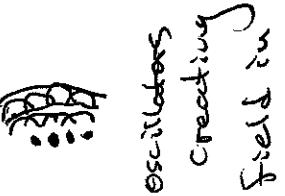
$$\vec{E} = E_0(r) e^{-i\omega t} e^{ikr_1} [1 + e^{is} + (e^{is})^2 + \dots + (e^{is})^{N-1}]$$

etc.  
In total So,

$$\vec{E} = E_0(r) e^{-i\omega t} e^{ikr_1} [1 + e^{ik(r_2-r_1)} + e^{ik(r_3-r_1)} + \dots + e^{ik(N-r_1)}]$$

performed by Krichhoff. For part 3  
now let's try to motivate it:  
a slit.

- Hence a slit is equivalent to oscillators creating fields in the gap.



↑ superposition  
of the  
two field  
electrons  
oscillate and  
create own field

Now,  $\vec{E} = k(r_2 - r_1) = dk \sin\theta, \dots$  etc.

$$(N-1)s = k(r_N - r_1) = k(N-1) \sin\theta$$

and so,

$$\begin{aligned} \vec{E} &= E_0(r) e^{-i\omega t} e^{ikr_1} [1 + e^{is} + (e^{is})^2 + \dots + (e^{is})^{N-1}] \\ &= E_0(r) e^{-i\omega t} e^{ikr_1} \left[ \frac{e^{isN} - 1}{e^{is} - 1} \right] \end{aligned}$$

$$\begin{aligned} &= E_0(r) e^{-i\omega t} \left[ e^{i\omega r_2} \left( \frac{e^{i\omega s/2} - e^{-i\omega s/2}}{e^{i\omega r_2} (e^{i\omega s/2} - e^{-i\omega s/2})} \right) \right] \end{aligned}$$

Then

$$\tilde{E} = E_0(r) e^{-i\omega t} e^{i(kr + (N-1)\delta/2)} \left( \frac{\sin \theta/2}{\sin \delta/2} \right)$$

but, the distance from the center of the slit to the screen is

$$R = \frac{1}{2}(N-1)d \sin \theta,$$

so

$$\tilde{E} = E_0(r) e^{-i(\omega R - \omega t)} \left( \frac{\sin \theta/2}{\sin \delta/2} \right)$$

and so

$$\tilde{I} = \frac{1}{2} \tilde{E} \tilde{E}^* = I_0 \frac{\sin^2(\theta/2)}{\sin^2(\delta/2)}$$

An excellent exercise for yourself is to confirm that

$$\frac{\sin^2(N\delta/2)}{\sin^2(\delta/2)} = N^2 \quad \text{for } S = 2m\pi$$

and hence that at the principle maximum

$$I = N^2 I_0.$$

where  $I_0$  is the intensity at  $P$  of a single one of the sources.

The interference pattern contains large "principal maxima" or smaller "local maxima". The principle maxima are in directions such that  $S = 2m\pi$ ,  $m = 0, \pm 1, \pm 2, \dots$  or when (since  $S = k d \sin \theta$ ),

$$d \sin \theta_m = m\pi, \quad m = 0, \pm 1, \pm 2, \dots$$